

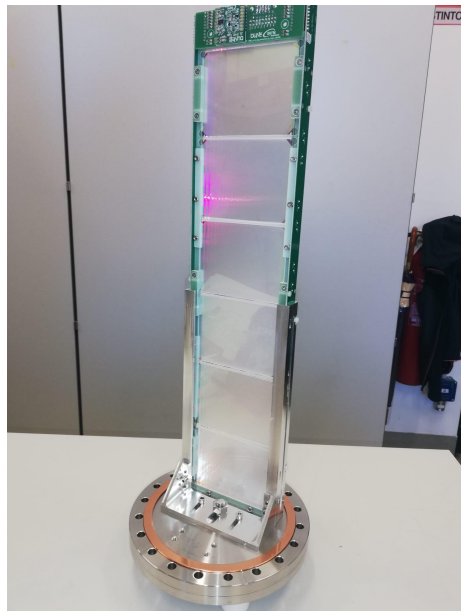
HD Supercell efficiency measurements in Liquid Argon @ Milano-Bicocca: updated results

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26/01/2022

Setup to measure the XA-HD-SC PDE in LAr

The XA-HD-SC w. Cold FE circuit (top)

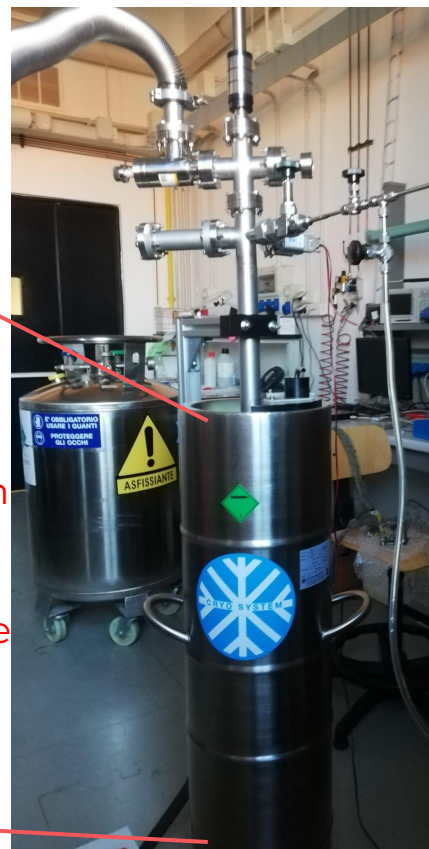
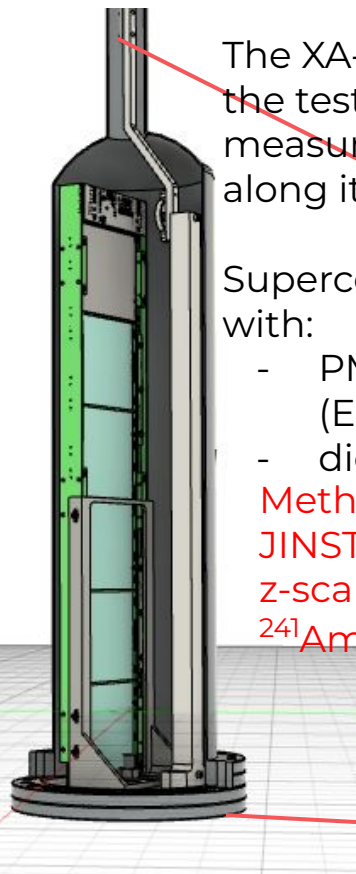


The XA-SC installed in the test chamber to measure the PDE along its z-axis.

Supercell equipped with:

- PMMA WLS (ELJ&G2P)
- dichroic filters

Method as published in JINST 16 (2021) 09027:
z-scanning with an ^{241}Am exposed α source

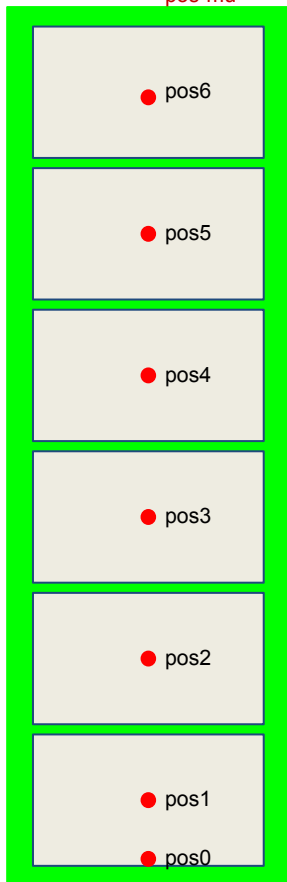


What we updated:

- Fixed a bug in the code for the efficiency computation.
- Changed sphe integration interval:
 - this update:
 - HPK: from 120 ns before the peak to 800 ns after the peak;
 - FBK: from 170 ns before the peak to 800 ns after the peak;
 - first release: HPK & FBK: from 60 ns before the peak to 800 ns after the peak;
- Changed alpha wfm integration interval
 - this update: HPK & FBK: from 400 ns before the peak to 1000 ns after the peak;
 - first release: HPK & FBK: from 300 ns before the peak to 600 ns after the peak;
- New measurements of SC efficiency w. FBK & Eljen lightguide: **New**
- Resolution vs $\sqrt{N_{\text{phe}}}$: **New**
- gain of detector vs V_{OV} : **New**
- Muon wfm deconvolution: **New**
- muon analysis: **New**

Method & Data taking

pos-mu

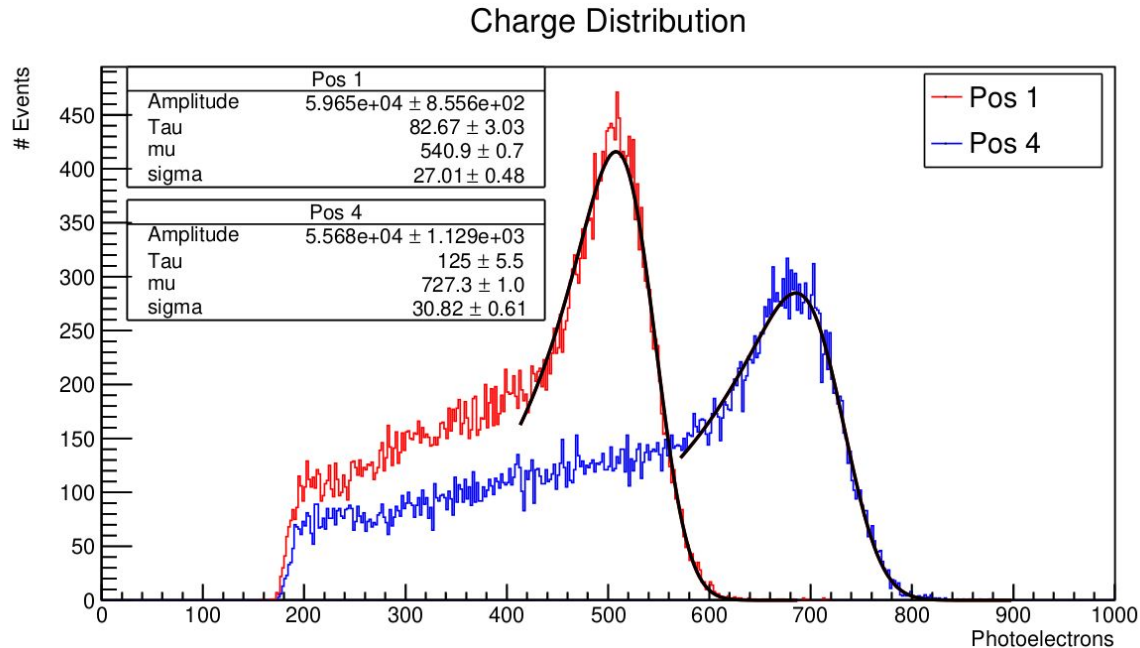


z-scanning of the SC with the ^{241}Am α (5.480 MeV) source at the following positions:

1. **pos0**: (the lowest possible): ~ 2 cm above the flange.
2. **pos1, 2, 3, 4, 5, 6**: the center of each dichroic filter.
Acquired: $10^4 \times 4$ wfms; 20 μs length; ~ 5 μs pretrigger.
3. Source at the topmost position (~ 49 cm from the flange) and \sim out of LAr:
 - one **μ run** ($10^4 \times 4$ events; 20 μs , 5 μs pretrigger)
 - one **s.p.h.e. run** ($10^4 \times 8$ events; 20 μs length; 1.6 μs pretrigger)

Source-to-dichroic filter distance: (55 +/- 1) mm.

Fit of alpha spectra: an example

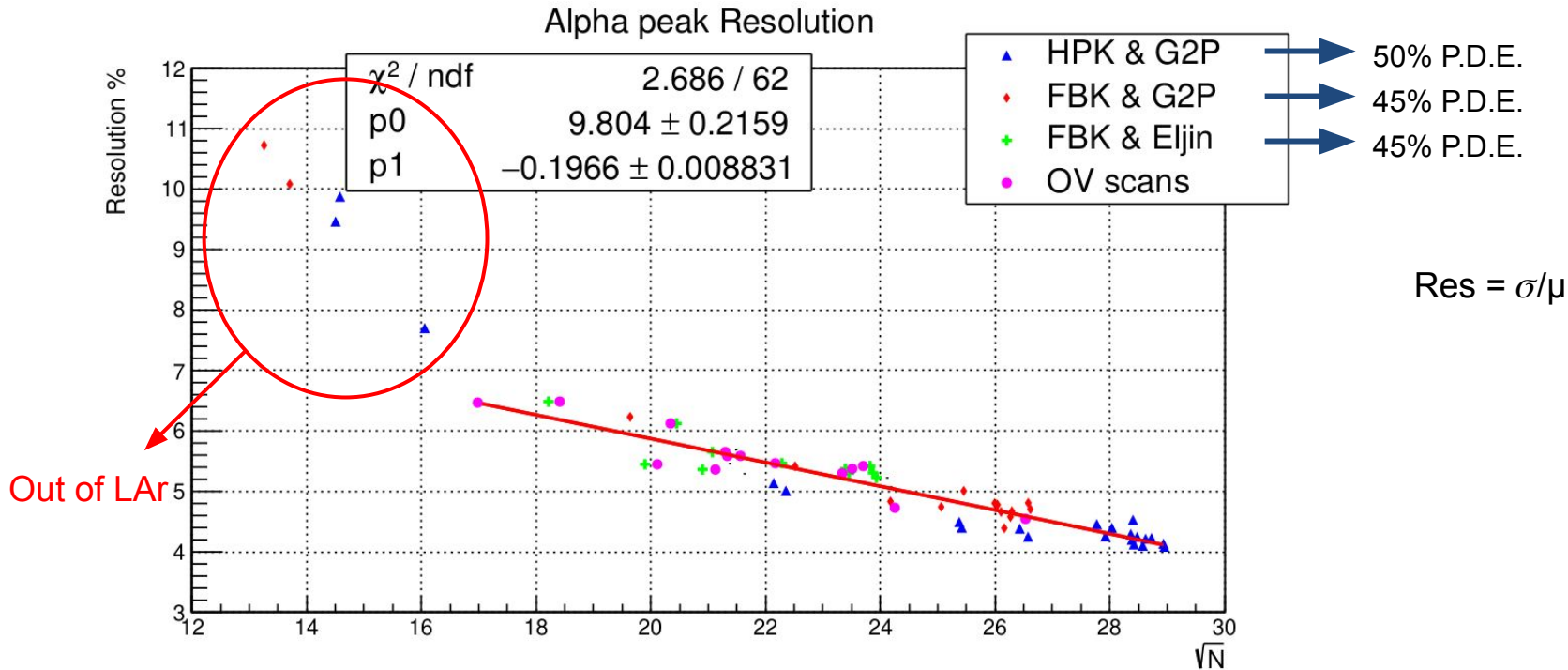


pos.1: $\sigma/\mu = 4.9 \%$

pos.4: $\sigma/\mu = 4.2 \%$

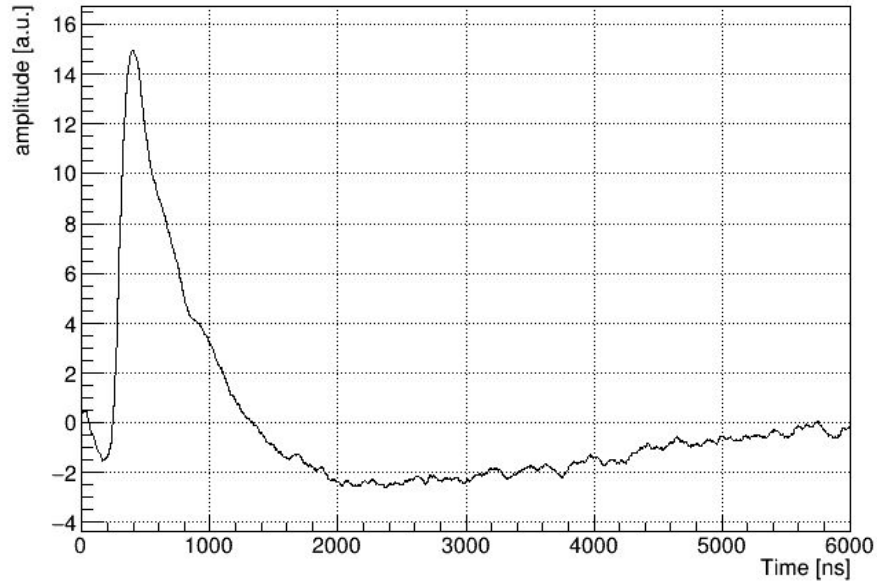
SC equipped with FBK & G2P

Resolution vs sqrt(n photoelectrons)

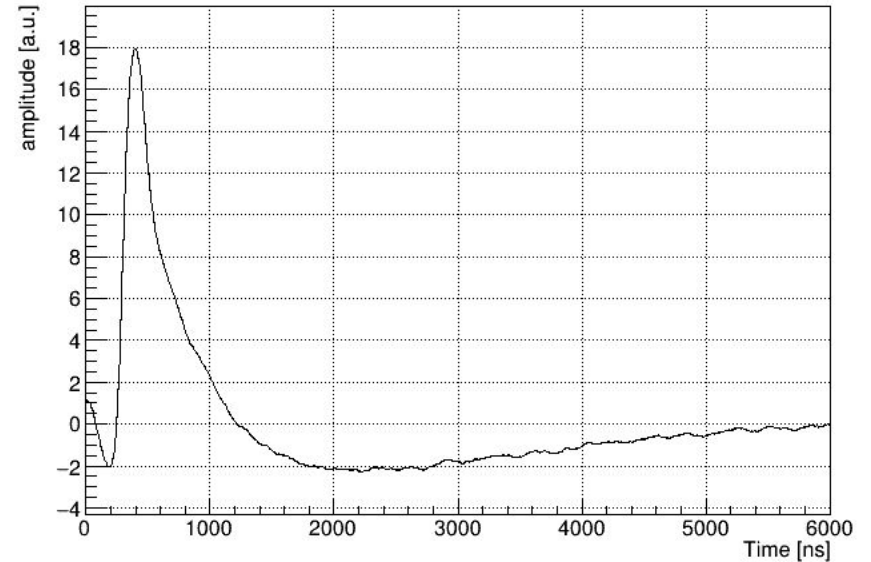


Single Photoelectrons mean waveform

FBK Average sphe waveform

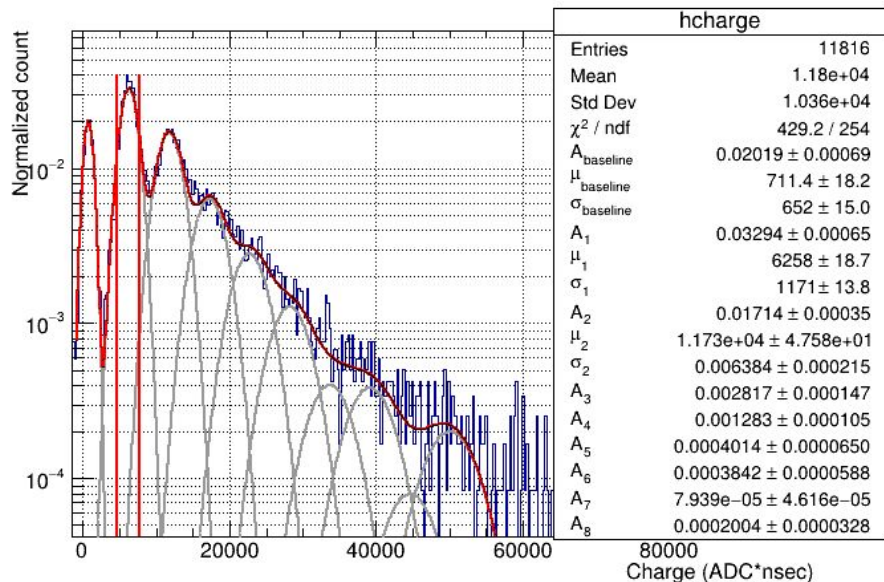


HPK Average sphe waveform

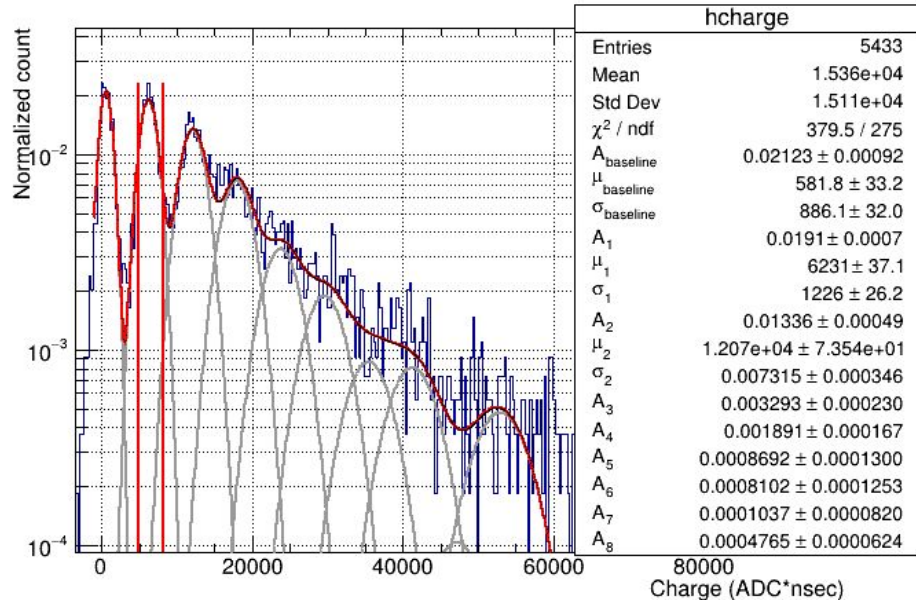


Single Photoelectrons spectrum

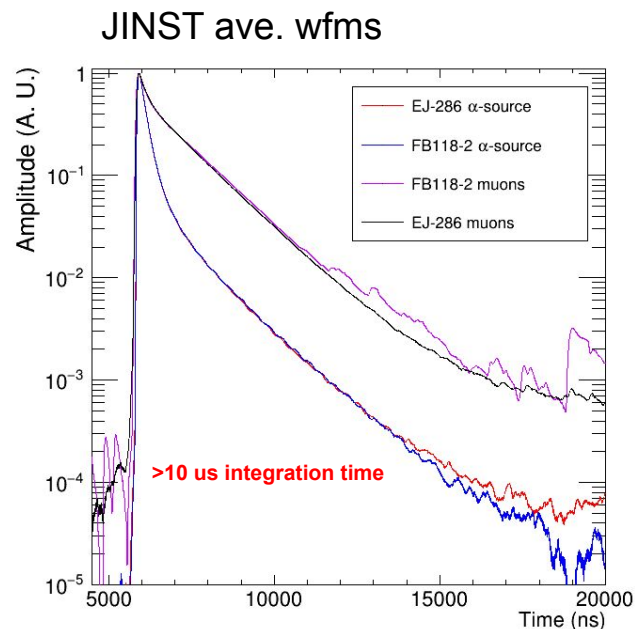
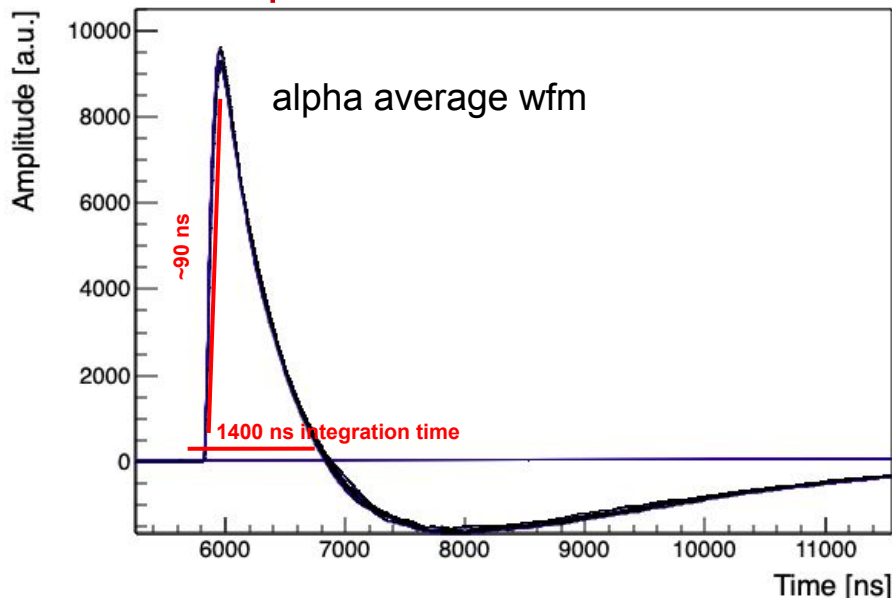
HPK S/N = 4.7



FBK S/N = 4.1

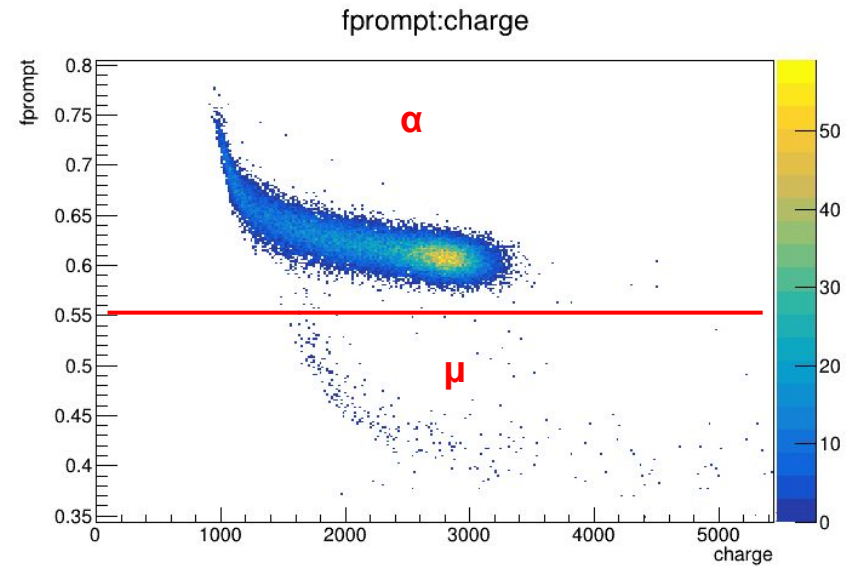
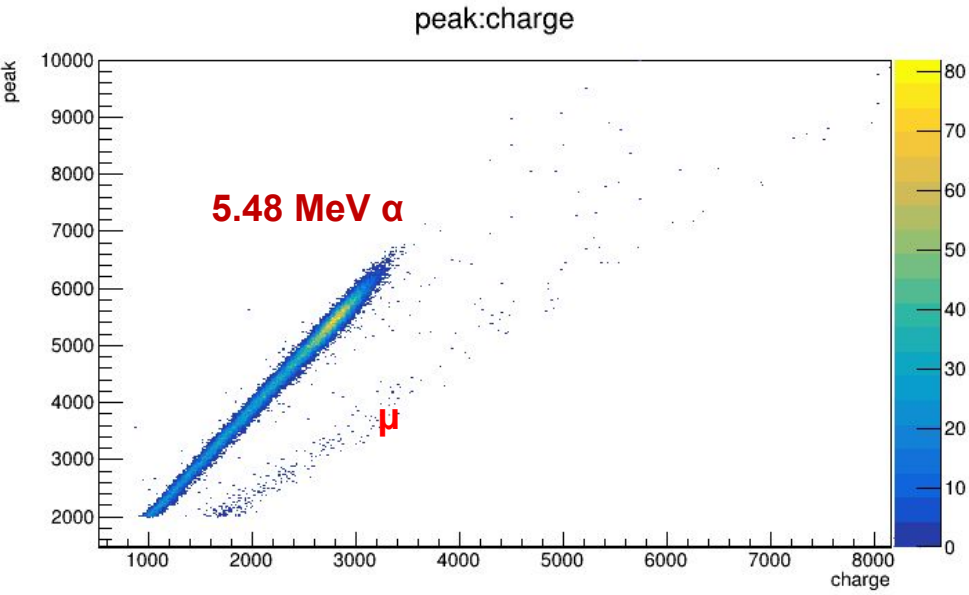


Pulse shape



- The wfm shows a long undershoot due to 1) the SiPMs AC and 2) cold-to-warm stage couplings. Due to undershoot we implemented different analysis than in JINST work
- No s.p.h.e. deconvolution: selection of long s.p.h.e. pulses in our data not yet ready \rightarrow Integrate for 900 nsec (600 ns from peak), to avoid the negative lobe
- Produce synthetic wfms by [LAR scnt. light time profile * s.p.h.e. response function from SiPMs studies @ CIEMAT]
- Determine the integrated (within 900 ns) fraction of singlet/triplet light on the synthetic wfm

Linearity and F_{prompt}



F_{prompt} vs charge:
cut at 0.55

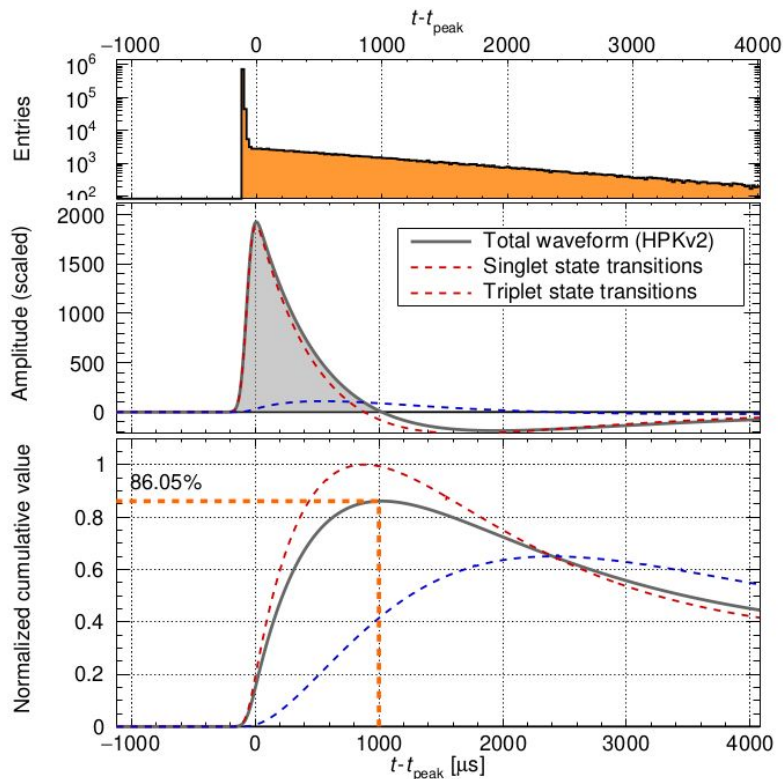
Linearity verified over > 1 decade

- α vs μ discrimination well achievable by F_{prompt}
- due to negative lobe in the present analysis **we are missing a large fraction of the slow component**

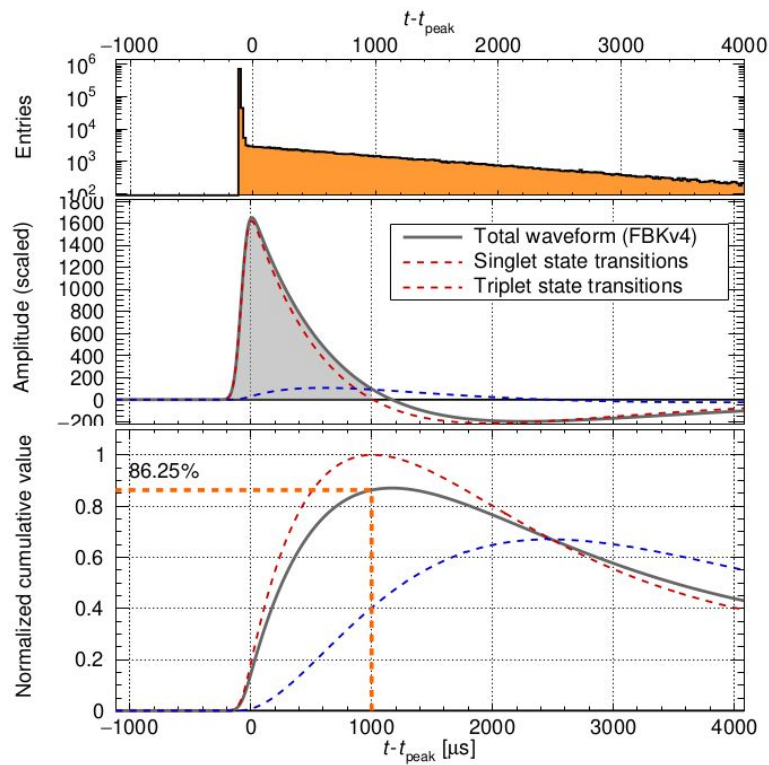
Fraction of integrated light

Synthetic wfms: SPHE \otimes LAr profile ($A_s=0.77$; $\tau_s=7\text{ns}$ $A_t=0.23$; $\tau_t=1400\text{ ns}$)

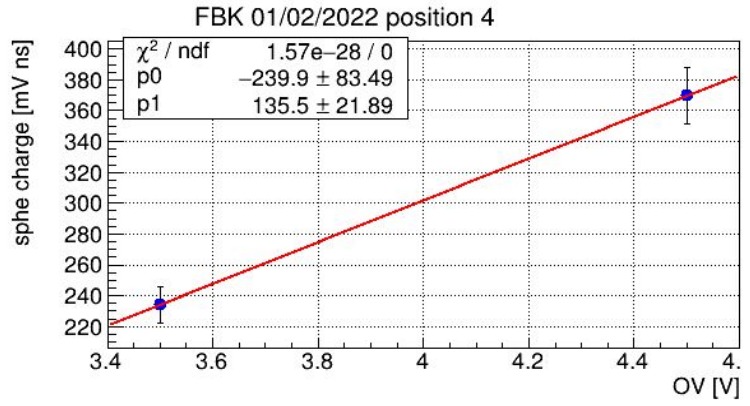
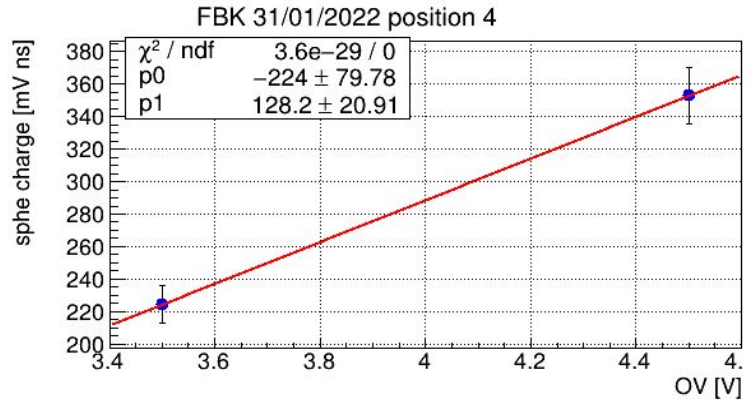
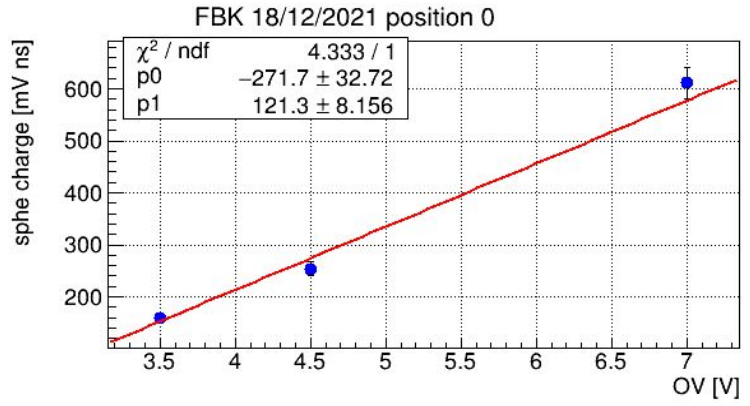
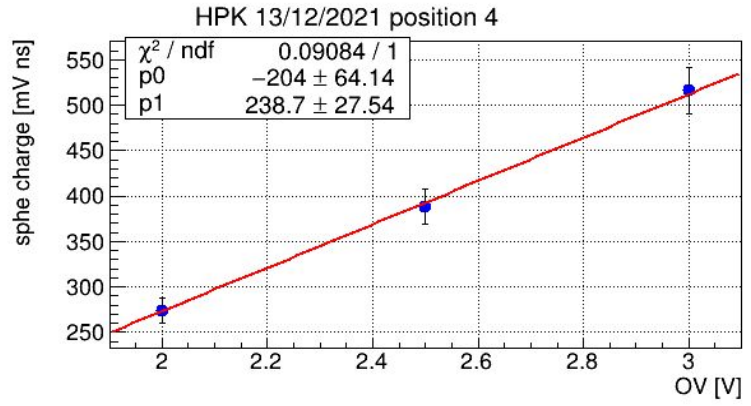
Fraction of Integrated light



Fraction of Integrated light

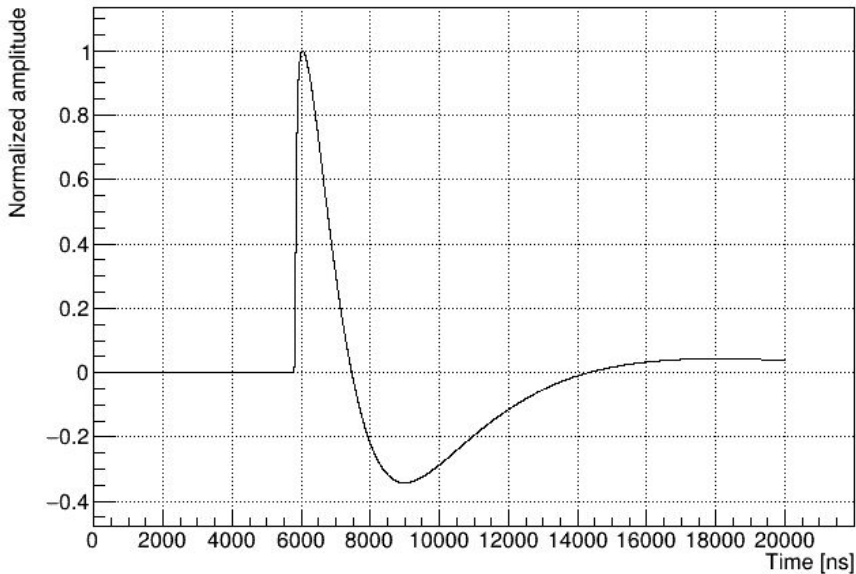


Gain vs V_{OV}

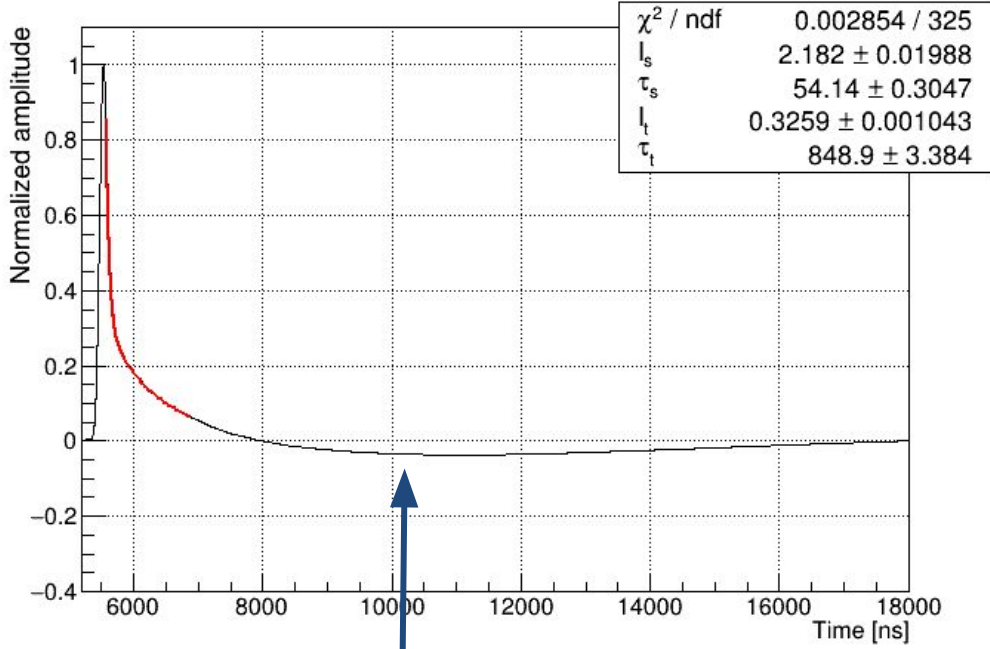


Deconvoluted muon waveform

Average muon waveform with FBK



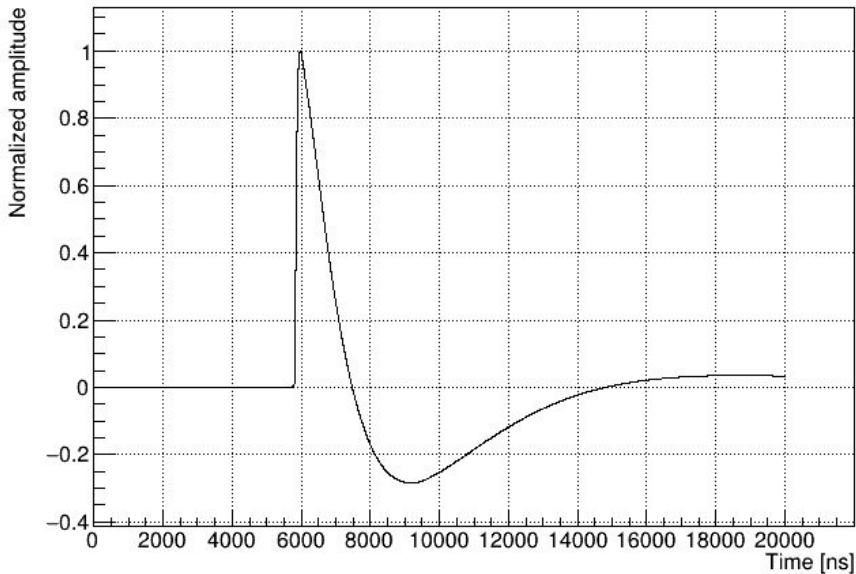
Deconvoluted muon waveform with FBK



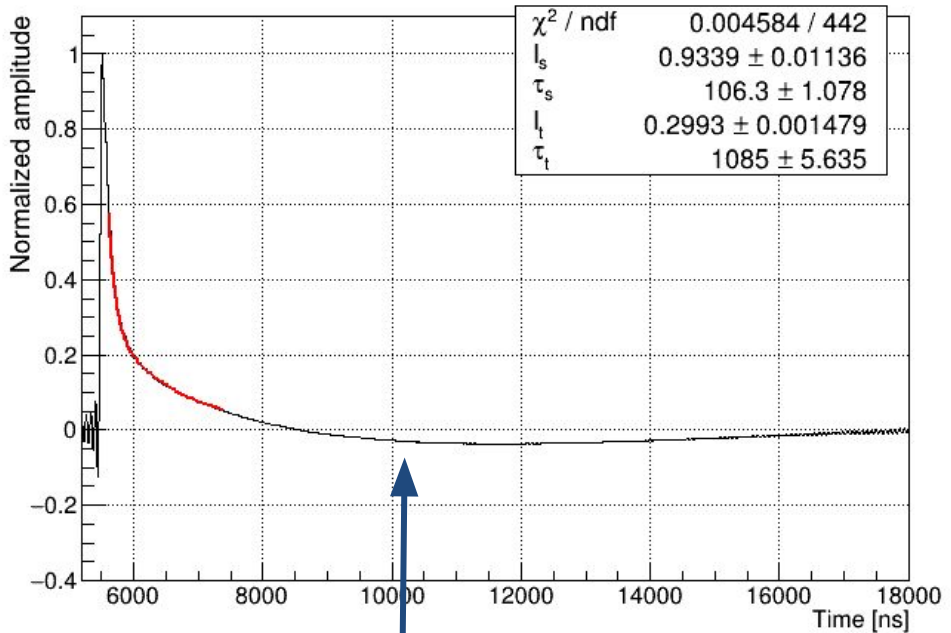
residual negative part

Deconvoluted muon waveform

Average muon waveform with HPK



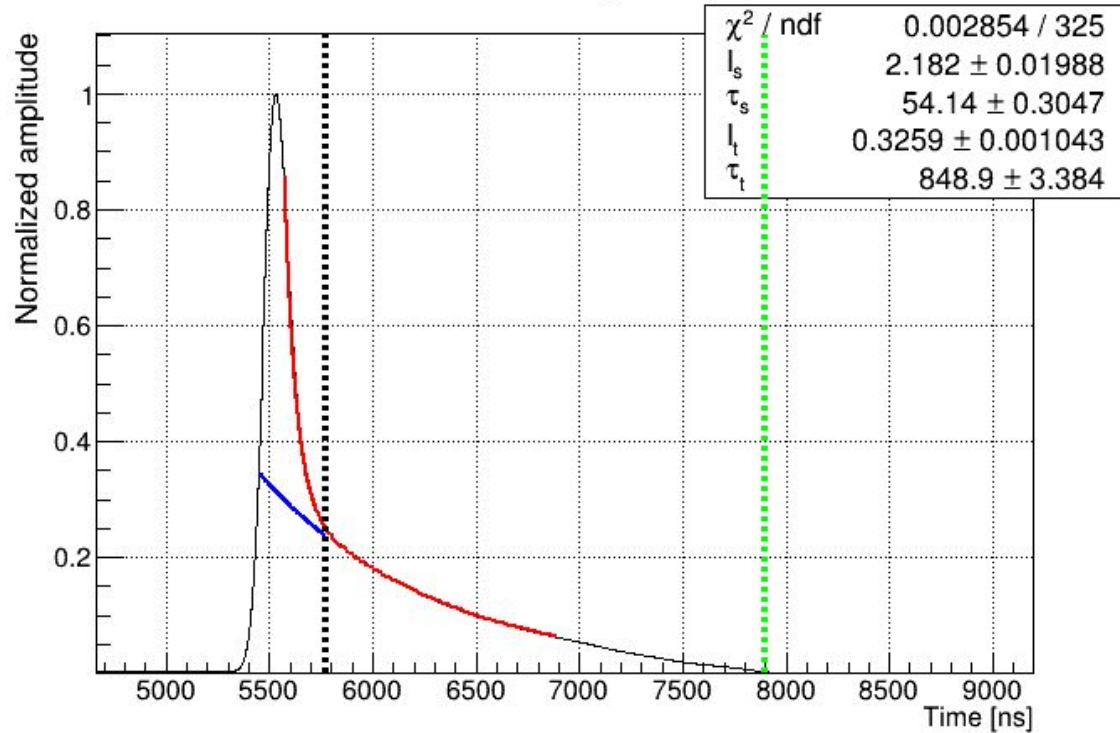
Deconvoluted muon waveform with HPK



residual negative part

Numerical evaluation of A_t/A_s

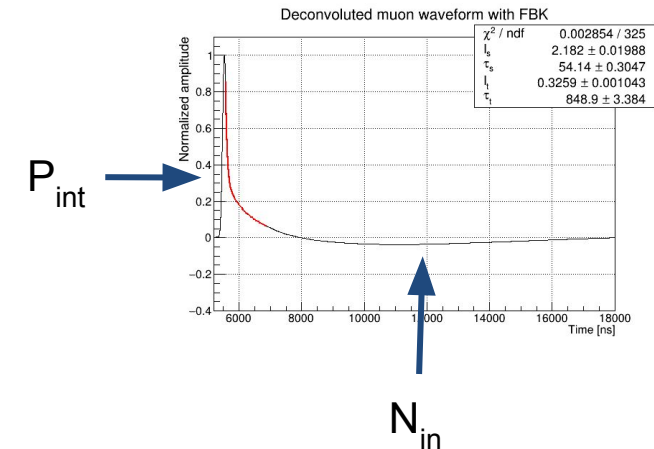
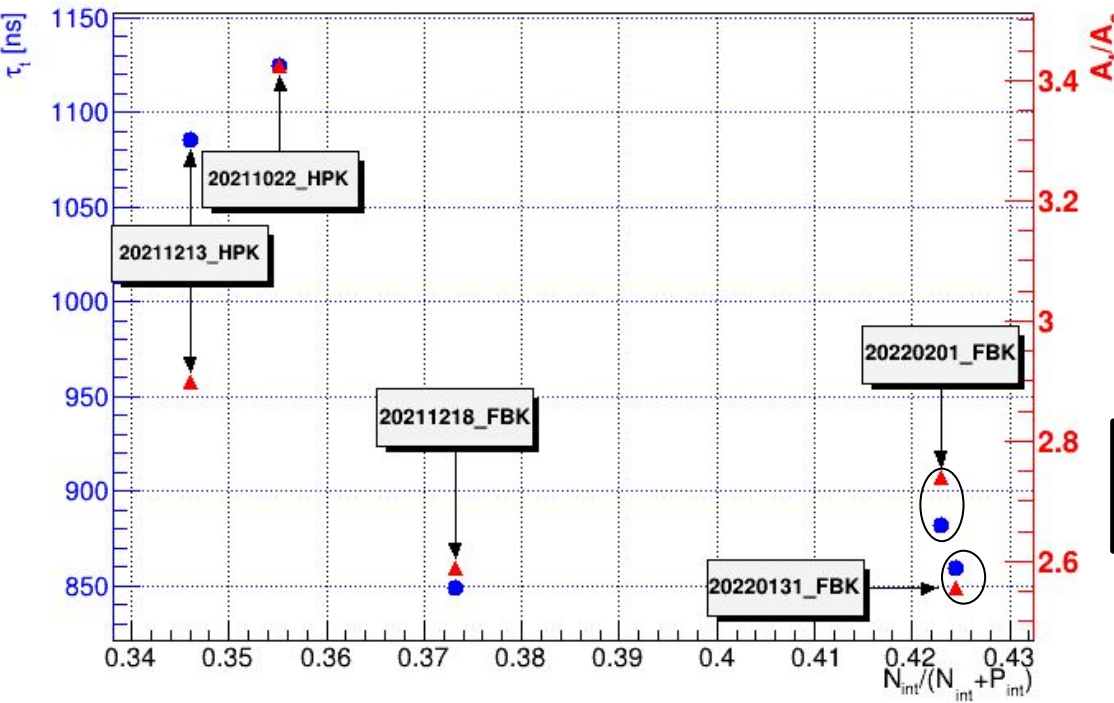
20211218_FBK



- Fit does not well represent I_s
- Numerical integration of singlet+triplet component (black dashed line)
- Analytic evaluation of triplet component (blue line) to obtain A_s (singlet component integral)

Residual negative part integral

Deconvoluted μ wvf: residual negative part integral

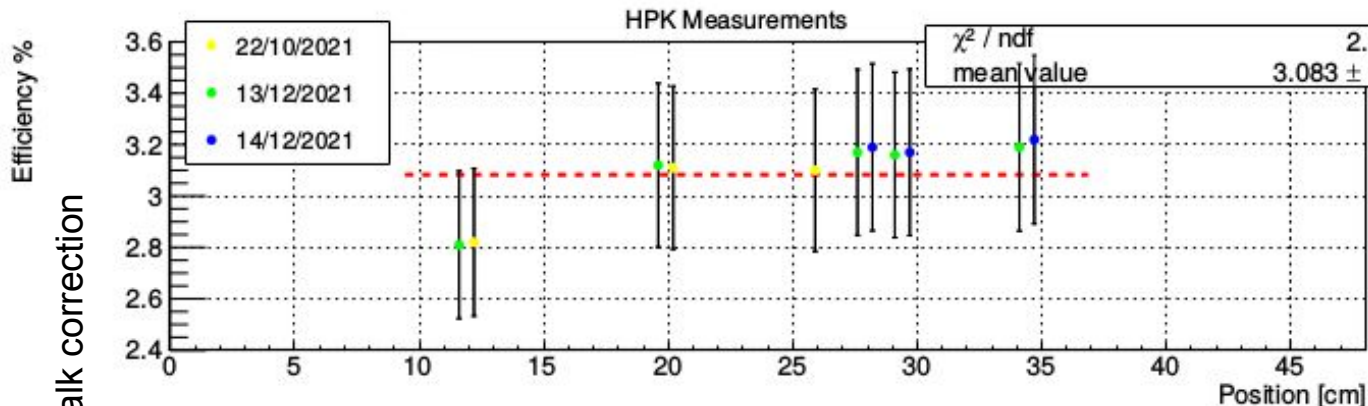


- Correlation between τ_t and A_t/A_s
- Dependence of N_{int} from SiPM type

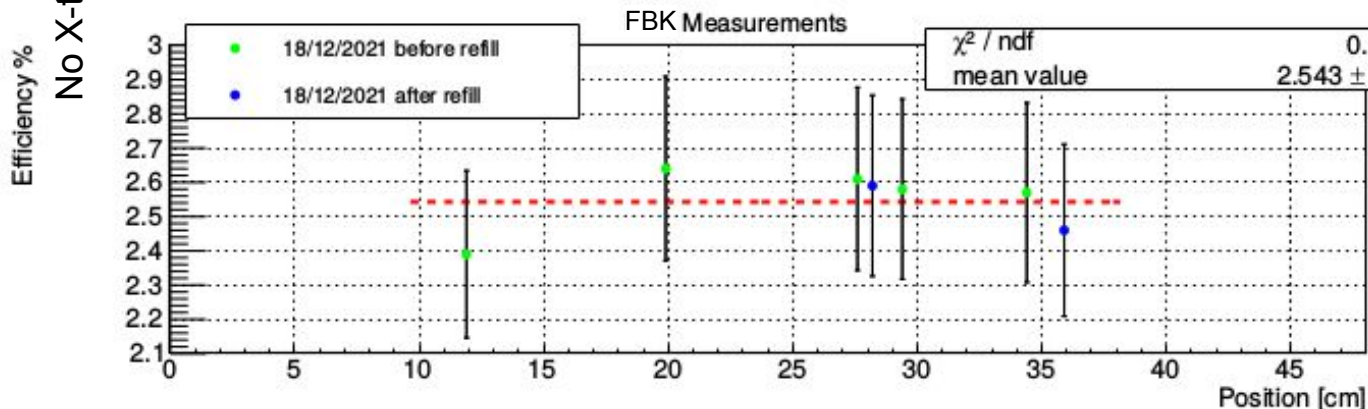
JINST: $A_t/A_s = 3.45 \pm 0.36$
 $\tau_t = 1414 \pm 21$ ns

Efficiency: previous presentation

$$\epsilon = \frac{4\pi \cdot \alpha \text{ peak(ADC)}}{\text{s.p.h.e.(ADC)} \cdot f_{int} \cdot LY_{LAr} \cdot En_{\alpha} \cdot q_{\alpha} \cdot \Omega}$$



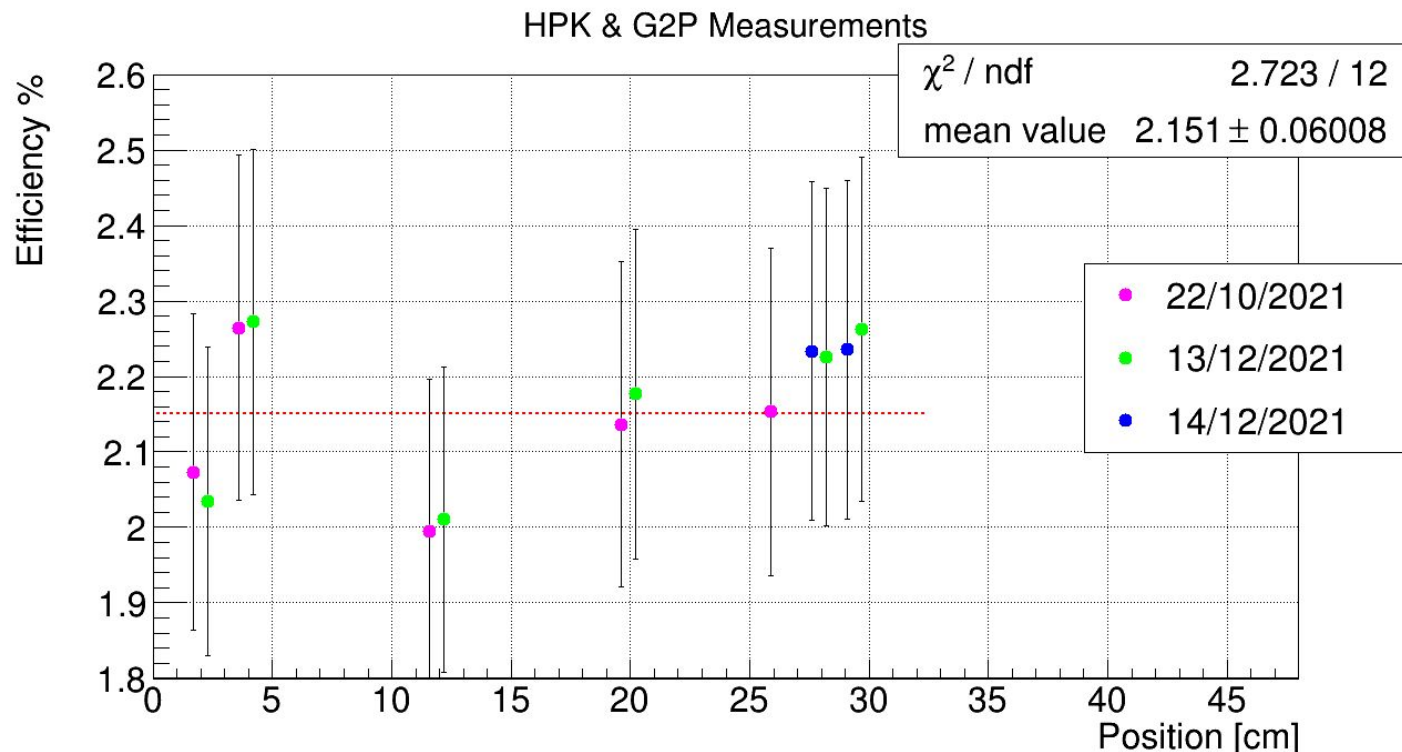
$LY_{LAr} = 5.1 \text{ E}+4$
 $q_{\alpha} = 0.72$
 $En_{\alpha} = 4.480 \text{ MeV}$
 $f_{int} = 0.7\text{-}\mathbf{0.8}$ (TBC,
 ~10% uncertainty)



$LY_{LAr} = 5.1 \text{ E}+4$
 $q_{\alpha} = 0.72$
 $En_{\alpha} = 4.480 \text{ MeV}$
 $f_{int} = 0.7\text{-}\mathbf{0.8}$ (TBC,
 ~10% uncertainty)

Efficiency: Updated results HPK & G2P

$$\epsilon = \frac{4\pi \cdot \alpha_{\text{peak}}(\text{ADC})}{\text{s.p.h.e.}(\text{ADC}) \cdot f_{\text{int}} \cdot \text{LY}_{\text{LAr}} \cdot E_{n\alpha} \cdot q_{\alpha} \cdot \Omega}$$

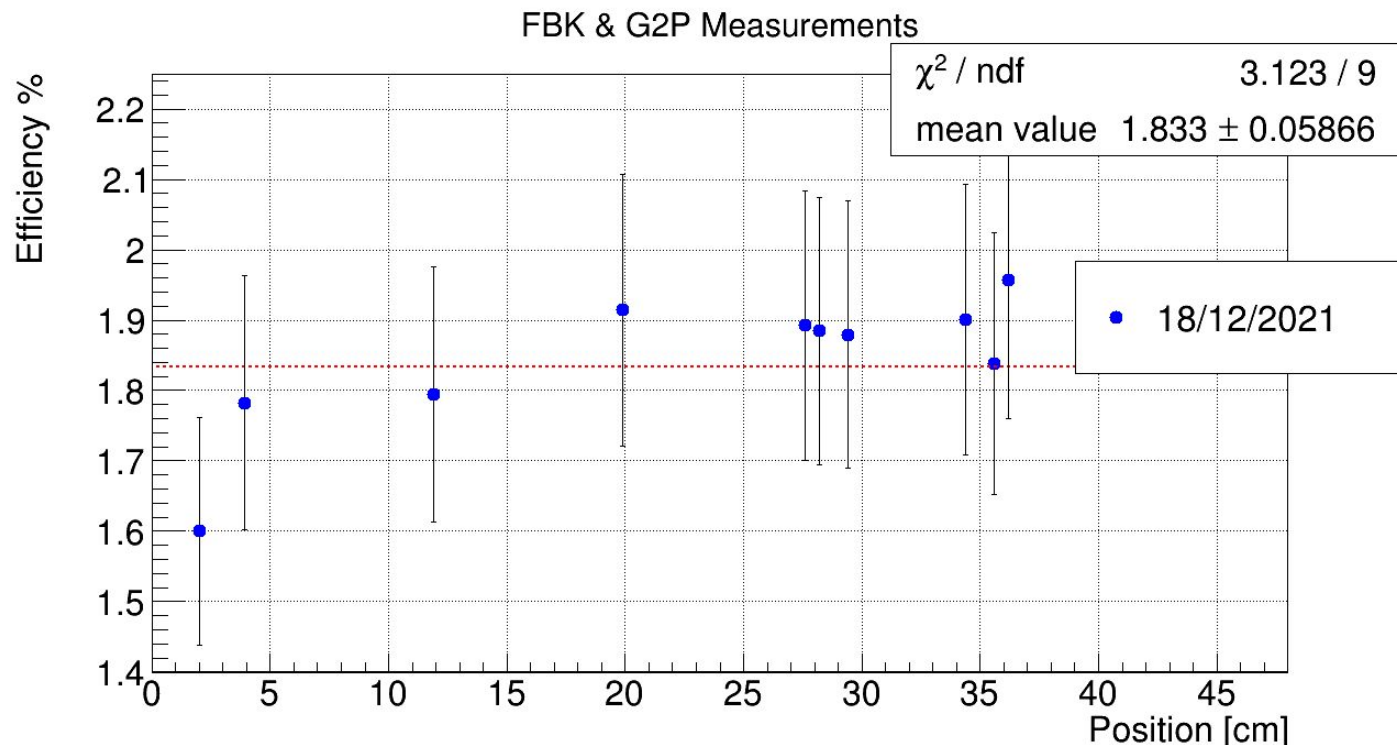


$\text{LY}_{\text{LAr}} = 5.0 \text{ E}+4$
 $q_{\alpha} = 0.7$
 $E_{n\alpha} = 5.480 \text{ MeV}$
 $f_{\text{int}}^{\alpha} = 0.862$

No X-talk and LAr
purity corrections

Efficiency: Updated results FBK & G2P

$$\epsilon = \frac{4\pi \cdot \alpha \text{ peak(ADC)}}{\text{s.ph.e.(ADC)} \cdot f_{int} \cdot LY_{LAr} \cdot En_{\alpha} \cdot q_{\alpha} \cdot \Omega}$$



$LY_{LAr} = 5.0 \text{ E}+4$
 $q_{\alpha} = 0.7$
 $En_{\alpha} = 5.480 \text{ MeV}$
 $f_{int} = 0.86$

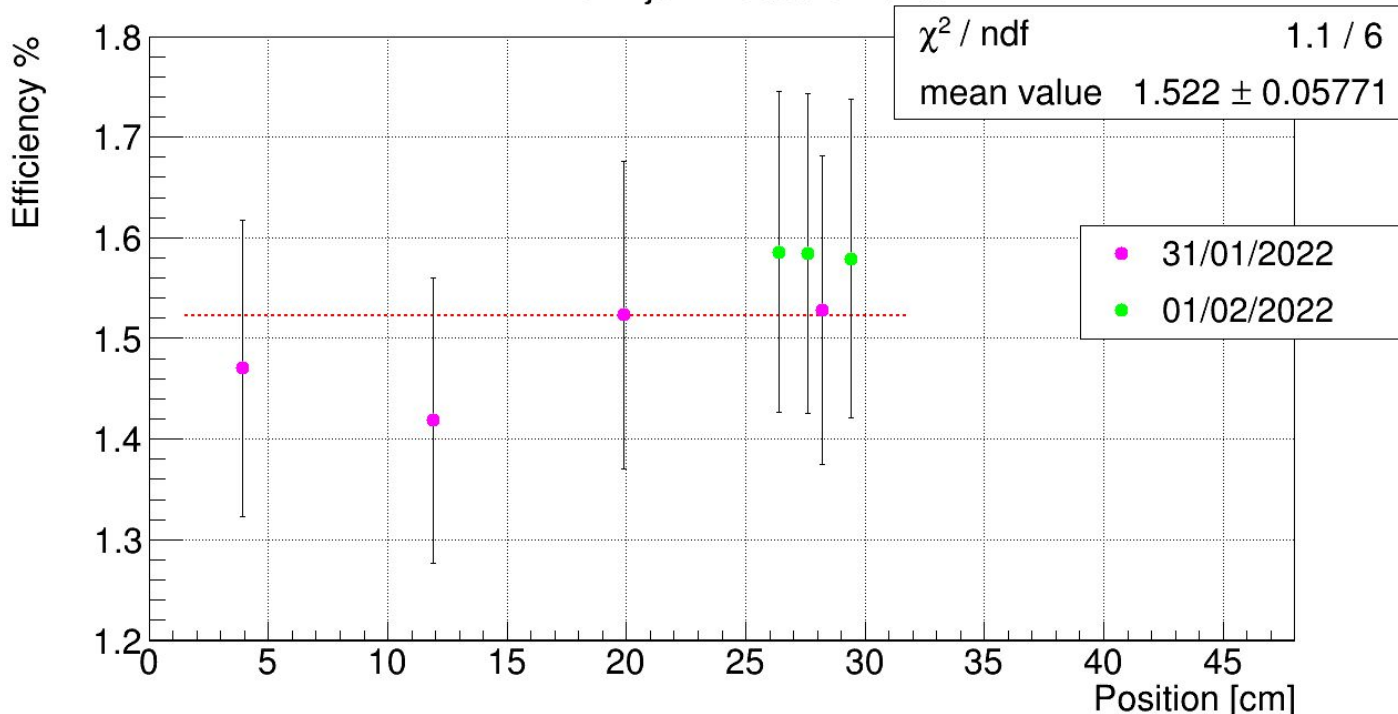
No X-talk and LAr
purity corrections

Efficiency: Updated results

FBK & Eljen

$$\epsilon = \frac{4\pi \cdot \alpha \text{ peak(ADC)}}{\text{s.p.h.e.(ADC)} \cdot f_{int} \cdot LY_{LAr} \cdot E_{n\alpha} \cdot q_{\alpha} \cdot \Omega}$$

FBK & Eljen Measurements



$LY_{LAr} = 5.0 \text{ E}+4$
 $q_{\alpha} = 0.7$
 $E_{n\alpha} = 5.480 \text{ MeV}$
 $f_{int} = 0.86$

No X-talk and LAr
purity corrections

Efficiency: X-talk and P_{LAr} corrections

		OV	PDE	Uncorrected ϵ_{XA}	Measured Xtalk	P_{LAr} correction	Corrected ϵ_{XA} x talk only	Corrected ϵ_{XA} x talk and P_{LAr}
this work	HPK** & G2P	3.0V	50%	2.15 (0.06)	6.62%	0.95	2.02 (0.05)	2.13
	FBK*** & G2P	4.5V	45%	1.83 (0.06)	15.7%	0.91	1.58 (0.05)	1.74
	FBK*** & Eljen	4.5V	45%	1.52 (0.06)	15.7%	0.91	1.31 (0.05)	1.44
JINST work	HPK commercial*	2.7V	45%	3.5 (0.1)	22%		2.9 (0.1)	

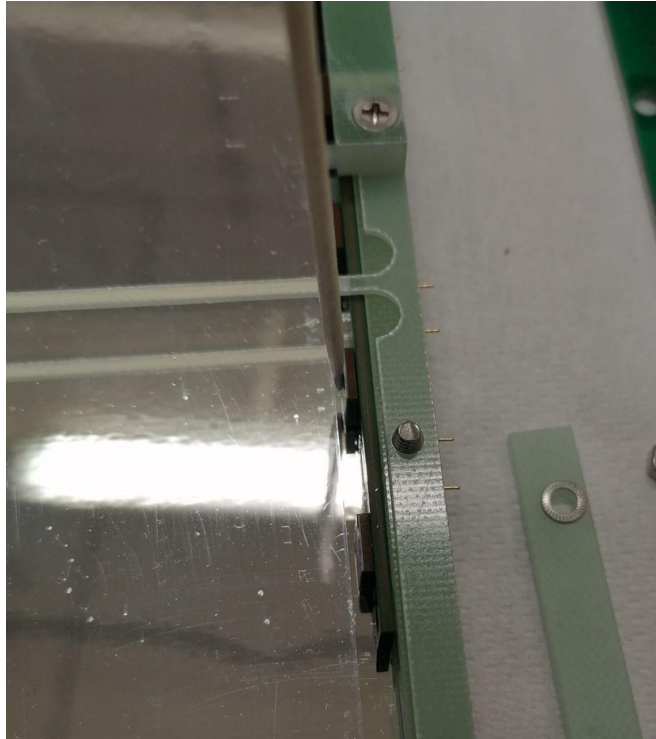
* S14160-6050HS (6 × 6) mm², 50 μm

** 75um-HQR

*** Triple Trench

$$P_{LAr} = \left(0.77 + 0.23 \times \frac{\tau_T}{1414 \text{ ns}} \right)^{-1}$$

Possible cause for lower efficiencies



Gap between the WLS bar and the SiPMs.
At room temperature, for G2P and HPK:
~1/1.5 mm overall.

At cyro temp probably: ~2 mm or more

Shrinking of G2P WLS bar: 8.3‰ (lower limit)

Shrinking of the frame: we tried to estimate the shrinking of the SiPM PCB (same material), with our method it wasn't observable/measurable.

Conclusions

- $S/N_{\text{HPK}} = 4.7$; $S/N_{\text{FBK}} = 4.1$, better than first release
- Verified linearity of resolution
- Verified linearity of gain vs V_{OV}
- Problems in deconvolution of muon average waveform
- Not sure about LAr purity correction.
- Supercell efficiency with cross talk (and LAr purity) correction:
 - HPK 2.02 (2.13) \pm 0.05%
 - FBK & G2P 1.58 (1.74) \pm 0.05%
 - FBK & Eljin 1.31 (1.44) \pm 0.05%

To Do

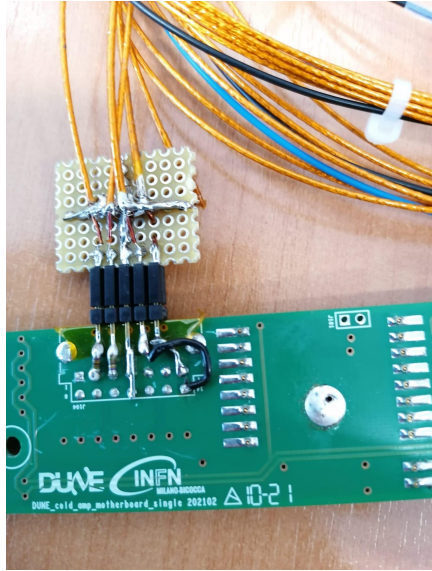
- Better estimation of LAr purity and muon analysis
- Deconvolution of alpha average waveforms
- Measurement of Eljen bar shrinking

Backup

Features of the XA HD Supercell under tests

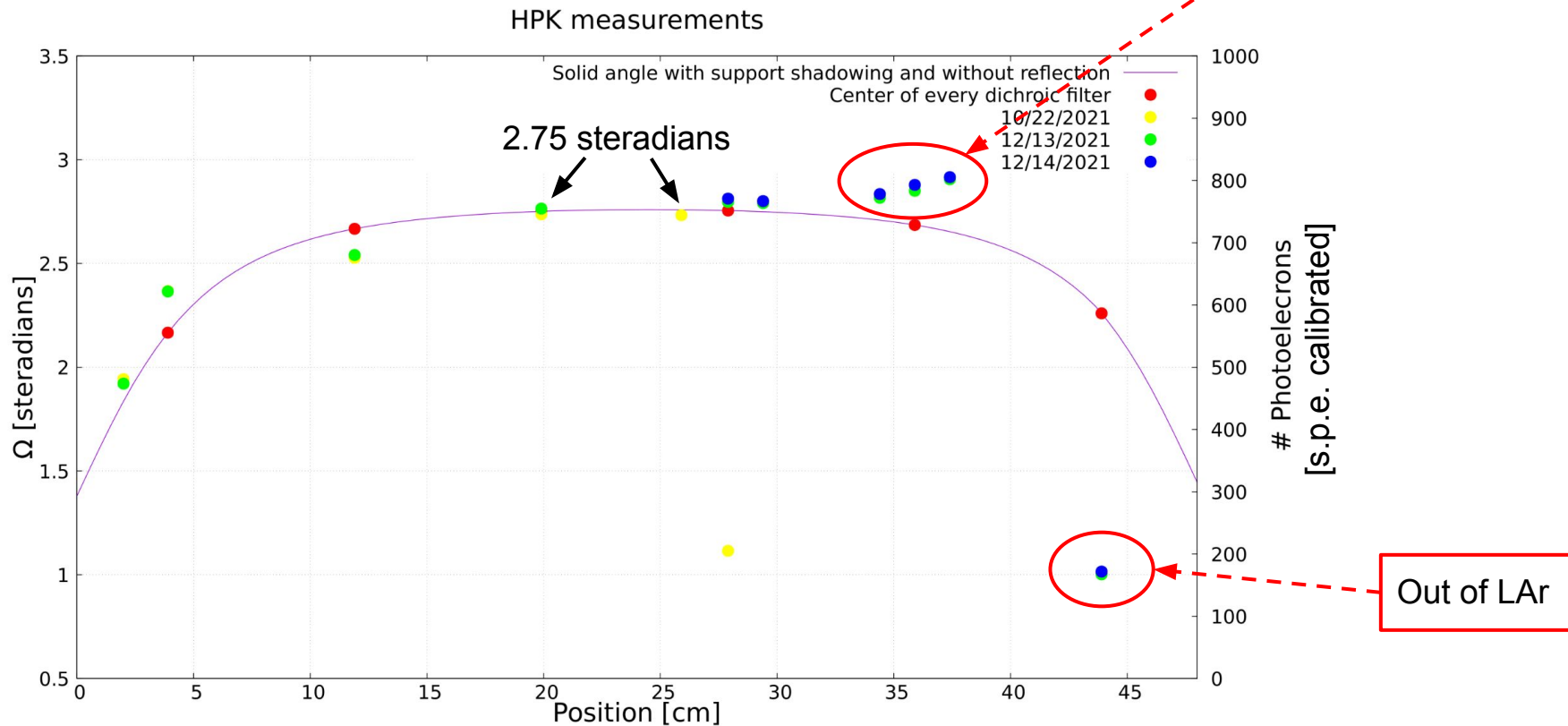
Size/type of the WLS slab Dichoics (sipm/WLS) area	G2P 480 x 93 mm ² , NO Vikuiti on short edges 6 x dichroics (Opto-Campinas) 3.9%
SIPMs	HPK DUNE-75um-HQR, +3V OV (50% PDE) FBK TT, +4.5V OV (45% PDE)
Ganging	x 48 SiPMs by MiB cold Amplifier
# electronic channels	1
SiPMs -Cold Amp. Cold Amp dyn. range	AC 2000 ph.e.
s.ph.e. (50 Ω , 45 V)	~ 2.0 mV on 50 Ω for both HPK and FBK
Chamber volume	~ 10 l
Digitizer	CAEN 14-bit 250 MS/sec, 4 ns/sample

Hardware



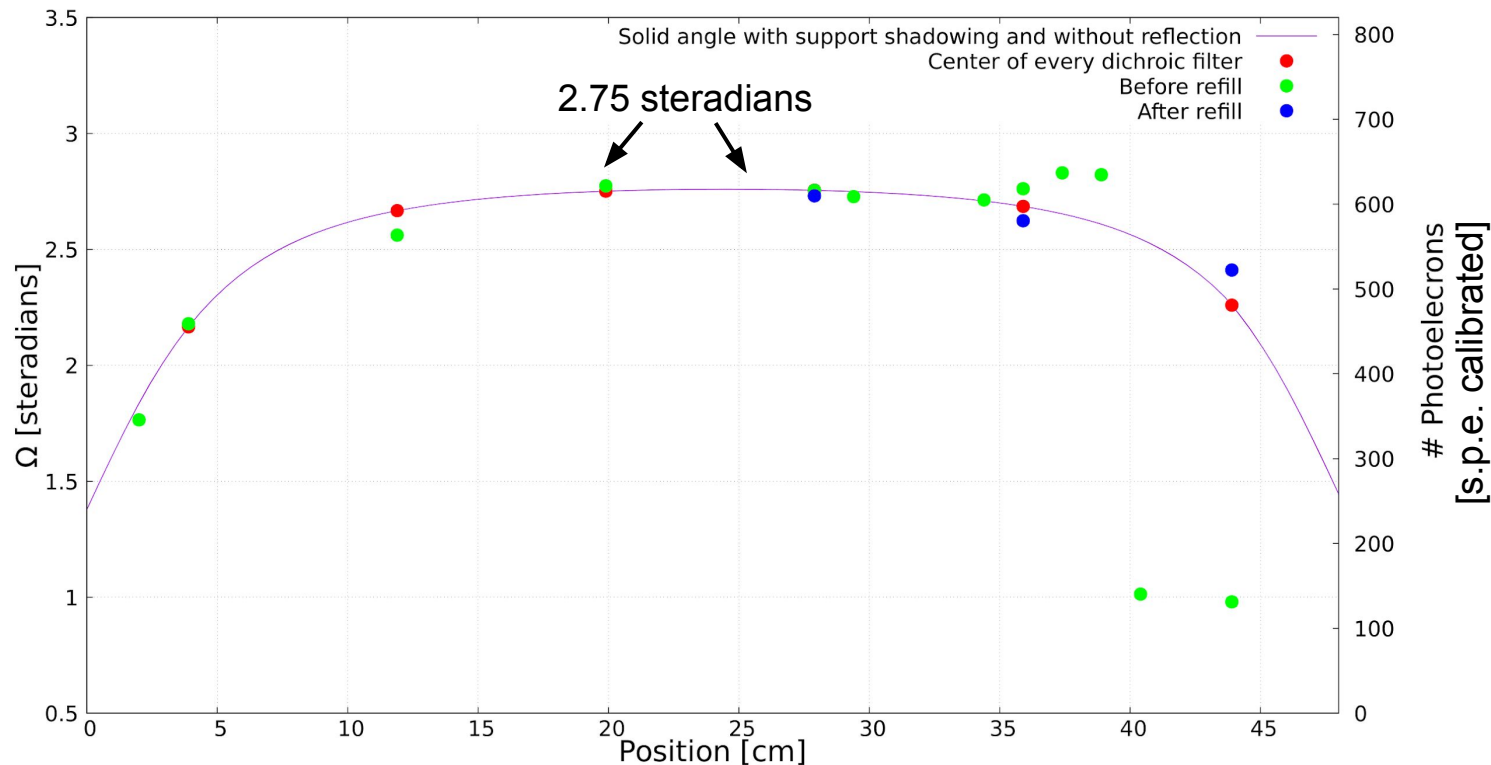
- Cold cables: a bundle of five Kapton RG178 coaxial cables. No DUNE blue cable & Hirose connector due to mechanical (dimension, stiffness) constraints of the setup
- Warm cables: 2.5 m, 50 Ω LEMO cables
- Cold-to-warm flange: 10 contacts vacuum/pressure connector mounted on a CF40 flange - No Hirose:
 - **the chamber and its payload are pumped down to 10^{-4} mbar prior filling \rightarrow**
 - **high LAr purity achieved with high reproducibility**
 - **the purity is maintained w.o. any recirculation along several days from filling**

Measurements with HPK (aggiornare)



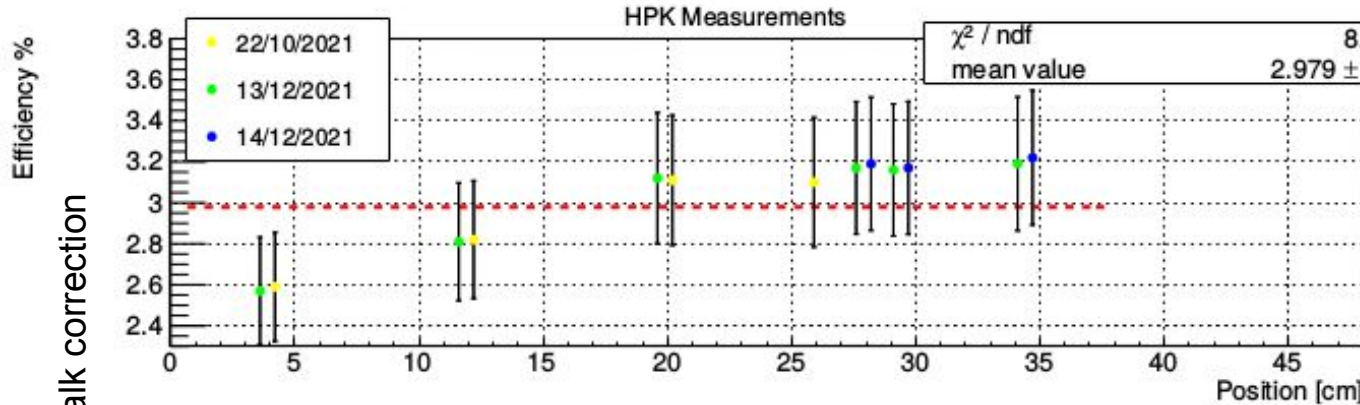
Measurements with FBK (aggiornare)

FBK measurements of 18/12

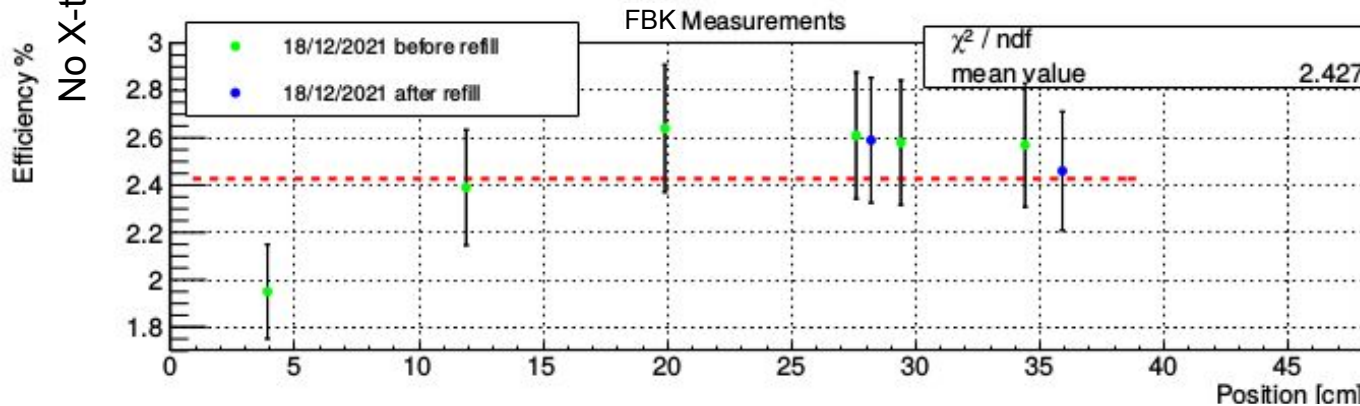


Efficiency: positions 1 to 5

$$\epsilon = \frac{4\pi \cdot \alpha \text{ peak(ADC)}}{\text{s.p.h.e.(ADC)} \cdot f_{int} \cdot LY_{LAr} \cdot En_{\alpha} \cdot q_{\alpha} \cdot \Omega}$$



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 $\sim 10\%$ uncertainty)

Cosa viene aggiornato in questo update

- //Corretto baco angolo solido disso al minimo valore (pos.1)
- Fixed a bug in the code for the efficiency computation.
- Changed sphe integration interval:
 - this update:
 - HPK: from 120 ns before the peak to 800 ns after the peak;
 - FBK: from 170 ns before the peak to 800 ns after the peak;
 - first release:
 - HPK & FBK: from 60 ns before the peak to 800 ns after the peak;
 - //S/N improved while gain unchanged
- integrazione alpha average wfm (selected at peak)
 - this update: (HPK&FBK: -400 ns to +1000 ns)
 - first release: (HPK&FBK: -300 ns to +600 ns)
- New measurements of SC efficiency w. FBK & ELjin lightguide: **New**
- alpha & muon wfm deconvolution: **New**
- muon analysis: **New**